

# Search Notes



Application/Control No.

10/664,112

Examiner

Henry K. Choe

Applicant(s)/Patent under Reexamination

LYNCH, JONATHAN

Art Unit

2817

## SEARCHED

Class	Subclass	Date	Examiner
330	~95	1/29/05	
"	1~4R	"	
"	84	"	
"	307	1/31/05	

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Term search (East)	1/31/05	H. C.
NPL (IEEE)	"	"